

# UNISONIC TECHNOLOGIES CO., LTD

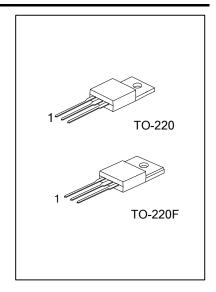
6N50 **Preliminary Power MOSFET** 

# 6 Amps, 500 Volts **N-CHANNEL POWER MOSFET**

### **DESCRIPTION**

The UTC 6N50 is an N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology allows a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

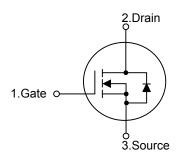
The UTC 6N50 is generally applied in high efficiency switch mode power supplies, active power factor correction and electronic lamp ballasts based on half bridge topology.



# **FEATURES**

- \* 6A, 500V,  $R_{DS(ON)}$ =1.15 $\Omega$  @  $V_{GS}$ =10V
- \* High Switching Speed
- \* 100% Avalanche Tested

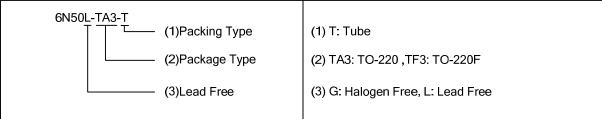
### **SYMBOL**



# **ORDERING INFORMATION**

Ordering Number		Dookogo	Pin	Dooking			
Lead Free	Halogen Free	Package	1	2	3	Packing	
6N50L-TA3-T	6N50G-TA3-T	TO-220	G	D	S	Tube	
6N50L-TF3-T	6N50G-TF3-T	TO-220F	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



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# **Power MOSFET**

# ■ **ABSOLUTE MAXIMUM RATINGS** (T<sub>C</sub>=25°C, unless otherwise specified)

PARAMETER			SYMBOL	RATINGS	UNIT	
Drain-Source Voltage			V <sub>DSS</sub>	500	V	
Gate-Source Voltage			$V_{GSS}$	±30	V	
Drain Current	Continuous (T <sub>C</sub> =25°C)		I <sub>D</sub>	6 *	Α	
Drain Current	Pulsed (Note 1)		I <sub>DM</sub>	24 *	V V A A A A A MJ MJ V/ns W W/°C °C	
Avalanche Current (Note 1)			I <sub>AR</sub>	6	Α	
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Single Pulsed (Note	Pulsed (Note 2)		270	mJ	
	mJ					
Peak Diode Recovery de	v/dt (Note 3)		dv/dt	4.5	V/ns	
	T -25°C	TO-220		89	14/	
T <sub>C</sub> =25°C		TO-220F		31	VV	
Power Dissipation	Dtb 05°0	TO-220	PD	0.71	W/°C	
	Derate above 25 C	TO-220F		0.24		
Junction Temperature		•	TJ	+150	°C	
Storage Temperature			T <sub>STG</sub>	-55~+150	°C	

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

# **■ THERMAL DATA**

PARAMETER	SYMBOL	RATINGS	UNIT		
lunction to Ambient	TO-220	0	62.5	°C/W	
Junction to Ambient	TO-220F	$\theta_{JA}$	62.5		
lunction to Coop	TO-220	0	1.4	°CAM	
Junction to Case	TO-220F	$\theta_{JC}$	4.0	°C/W	

<sup>\*</sup> Drain current limited by maximum junction temperature

# ■ **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub>=25°C, unless otherwise noted)

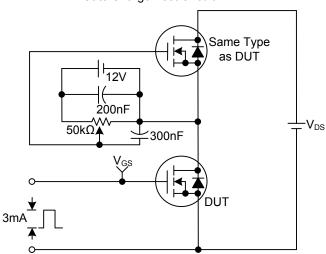
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		$BV_{DSS}$	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V				V
Drain-Source Leakage Current		$I_{DSS}$	V <sub>DS</sub> =500V, V <sub>GS</sub> =0V			1	μA
Gate- Source Leakage Current	Forward		V <sub>GS</sub> =+30V, V <sub>DS</sub> =0V			+100	nA
Gate- Source Leakage Current	Reverse	I <sub>GSS</sub>	$V_{GS}$ =-30V, $V_{DS}$ =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$			4.0	V
Static Drain-Source On-State Re	sistance	R <sub>DS(ON)</sub>	$V_{GS}$ =10V, $I_D$ =3A		0.95	1.15	Ω
DYNAMIC PARAMETERS							
Input Capacitance		$C_{ISS}$			720	960	pF
Output Capacitance Reverse Transfer Capacitance		Coss	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1.0MHz		85	115	pF
		$C_{RSS}$			6.3	10	pF
SWITCHING PARAMETERS							
Total Gate Charge	otal Gate Charge		\/ =10\/ \/ =400\/   =6A		15	20	nC
Gate to Source Charge		$Q_GS$	V <sub>GS</sub> =10V, V <sub>DS</sub> =400V, I <sub>D</sub> =6A		4.5		nC
Gate to Drain Charge		$Q_GD$	(Note 4, 5)		6		nC
Turn-ON Delay Time		$t_{D(ON)}$			17	45	ns
Rise Time		$t_R$	$V_{DD}$ =250V, $I_{D}$ =6A, $R_{G}$ =25 $\Omega$		30	70	ns
Turn-OFF Delay Time		$t_{D(OFF)}$	(Note 4, 5)		35	80	ns
Fall-Time		$t_{F}$	7		20	50	ns
SOURCE- DRAIN DIODE RATIN	NGS AND	CHARACTERI	STICS				
Maximum Body-Diode Continuou	us Current	I <sub>S</sub>				6	Α
Maximum Body-Diode Pulsed Current		I <sub>SM</sub>				24	Α
Drain-Source Diode Forward Voltage		$V_{SD}$	I <sub>S</sub> =6A, V <sub>GS</sub> =0V			1.5	V
Body Diode Reverse Recovery Time		t <sub>RR</sub>	I <sub>S</sub> =6A, V <sub>GS</sub> =0V, dI <sub>F</sub> /dt=100A/μs		85		ns
Body Diode Reverse Recovery C	Charge	$Q_{RR}$	(Note 4)		0.15		μC

Notes: 1. Repetitive Rating: Pulse width limited by maximum junction temperature

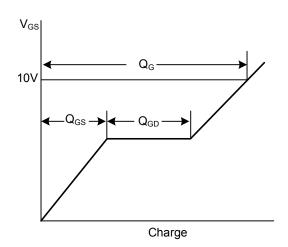
- 2. L =13mH,  $I_{AS}$  = 6A,  $V_{DD}$  = 50V,  $R_G$  = 25 $\Omega$ , Starting  $T_J$  = 25 $^{\circ}$ C
- 3.  $I_{SD} \le 6A$ , di/dt  $\le 200A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$
- 4. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%
- 5. Essentially independent of operating temperature

# **■ TEST CIRCUITS AND WAVEFORMS**

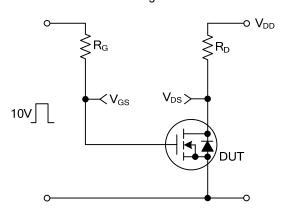
Gate Charge Test Circuit



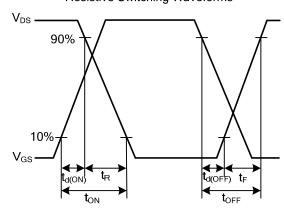
Gate Charge Waveforms



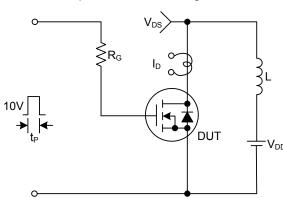
Resistive Switching Test Circuit



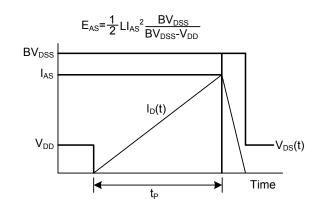
Resistive Switching Waveforms



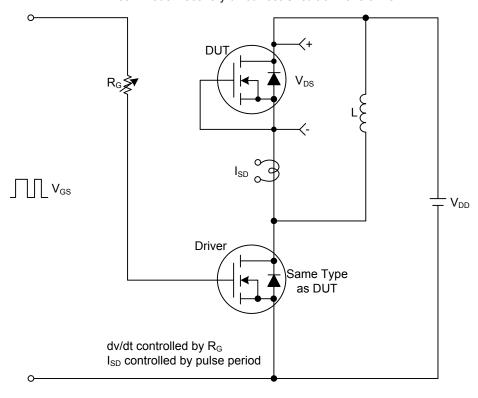
Unclamped Inductive Switching Test Circuit

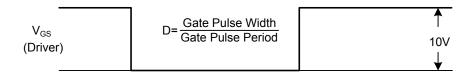


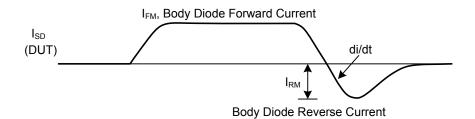
Unclamped Inductive Switching Waveforms

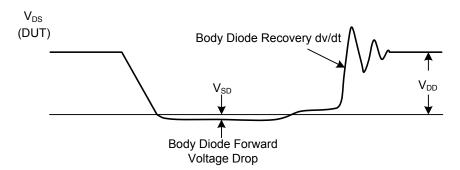


Peak Diode Recovery dv/dt Test Circuit & Waveforms









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